

The project team under the leadership of Dr.R.Govindaraj has been conferred with the CSIR-CEERI Foundation Day Award for Recognition of Excellence in Technology Development and Delivery for the Technology entitled "Dual Energy X-ray Image Analysis Technique for Material Discrimination" on the occasion of CSIR-CEERI's 66th Foundation Day Function held on 21st September 2018 at CSIR-CEERI, Pilani.



The award was received by Dr.R.Govindaraj on behalf of the project team, from the Guest of Honour, Prof.V.Ramgopal Rao, Director, IIT-Delhi. New Delhi